

MOS FIELD EFFECT TRANSISTOR μ PA1717

SWITCHING P-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The μ PA1717 is P-Channel MOS Field Effect Transistor designed for power management applications of notebook computers.

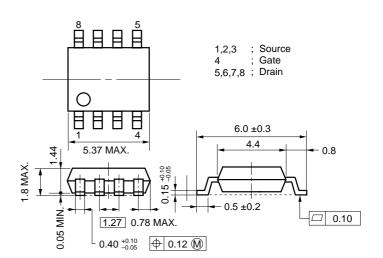
FEATURES

- · Low on-state resistance
 - $R_{DS(on)1} = 33~m\Omega~MAX.~(V_{GS} = -10~V,~I_{D} = -3~A)$ $R_{DS(on)2} = 59~m\Omega~MAX.~(V_{GS} = -4.5~V,~I_{D} = -3~A)$
- Low Ciss: Ciss = 830 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1717G	Power SOP8

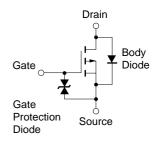
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, All terminals are connected.)

Drain to Source Voltage (Vcs = 0 V)	VDSS	-30	V
Gate to Source Voltage (Vps = 0 V)	Vgss	∓ 25	V
Drain Current (DC)	ID(DC)	∓ 6	Α
Drain Current (pulse) Note1	ID(pulse)	∓ 24	Α
Total Power Dissipation $(TA = 25^{\circ}C)^{Note2}$	Рт	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

EQUIVALENT CIRCUIT



- **Notes 1.** PW \leq 10 μ s, Duty Cycle \leq 1 %
 - 2. Mounted on ceramic substrate of 1200 mm² x 2.2 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.



ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

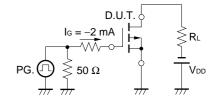
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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = -10 V, ID = -3 A		26	33	mΩ
	RDS(on)2	Vgs = -4.5 V, lb = -3 A		44	59	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.5	-2.0	-2.5	V
Forward Transfer Admittance	yfs	V _{DS} = -10 V, I _D = -3 A	3.0	7.5		S
Drain Leakage Current	loss	V _{DS} = -30 V, V _{GS} = 0 V			-1	μΑ
Gate to Source Leakage Current	Igss	Vss = ∓ 25 V, Vbs = 0 V			∓ 10	μΑ
Input Capacitance	Ciss	V _{DS} = -10 V		830		pF
Output Capacitance	Coss	V _{GS} = 0 V		330		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		130		pF
Turn-on Delay Time	td(on)	Ib = -3 A		15		ns
Rise Time	tr	$V_{GS(on)} = -10 \text{ V}$		120		ns
Turn-off Delay Time	td(off)	V _{DD} = -15 V		70		ns
Fall Time	t _f	$R_G = 6 \Omega$		50		ns
Total Gate Charge	Q _G	Ib = -6 A		15		nC
Gate to Source Charge	Qgs	V _{DD} = -24 V		3		nC
Gate to Drain Charge	Q _{GD}	V _G S = -10 V		5		nC
Body Diode Forward Voltage	VF(S-D)	IF = 6 A, VGS = 0 V		0.82		V
Reverse Recovery Time	trr	IF = 6 A, VGS = 0 V		35		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A / μs		15		nC

TEST CIRCUIT 1 SWITCHING TIME

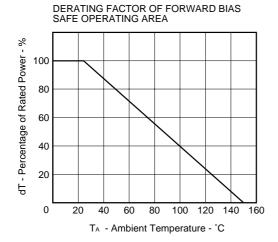
PG. $\begin{array}{c} D.U.T. \\ R_G \\ \end{array}$ $\begin{array}{c} V_{CS} \\ Wave Form \\ \end{array}$

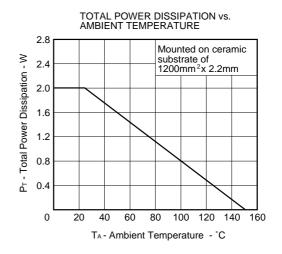
VGS (-) VGS(ON) 90 % Wave Form | 10 % | VGS(ON) 90 % ID (-) 90 % | 10 % | 10 % Wave Form | 10 % | 10 % To (10 %) | 10 % | 10 %

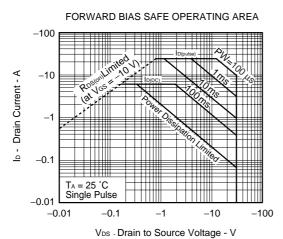
TEST CIRCUIT 2 GATE CHARGE



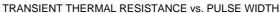
TYPICAL CHARACTERISTICS (TA = 25 °C)

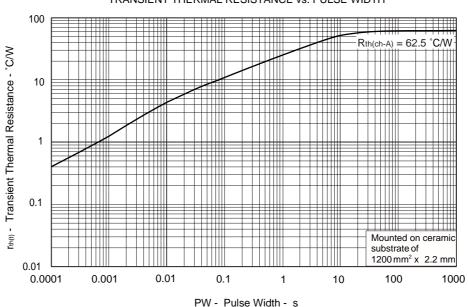




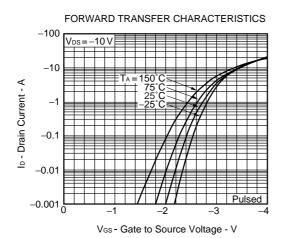


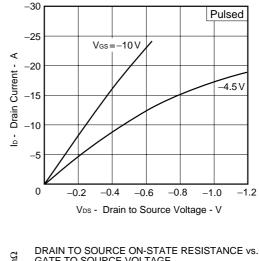
Remark Mounted on ceramic substrate of 1200 mm² x 2.2 mm



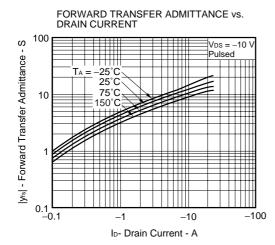


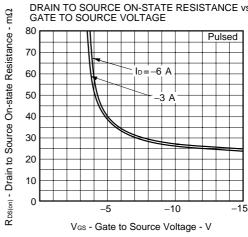
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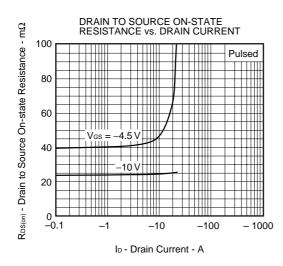


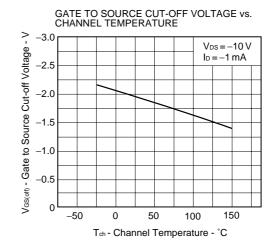


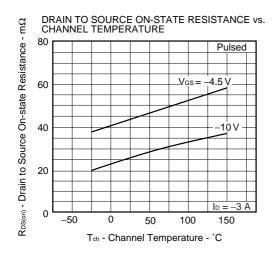
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

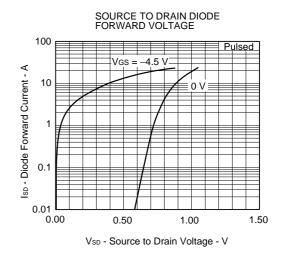


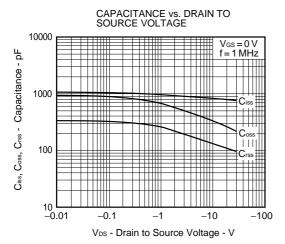


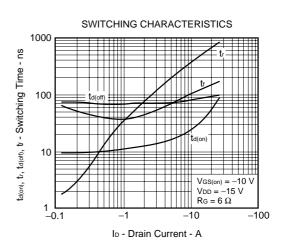


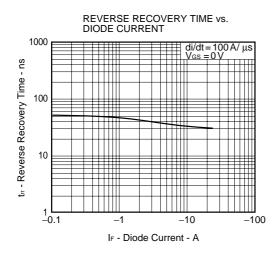


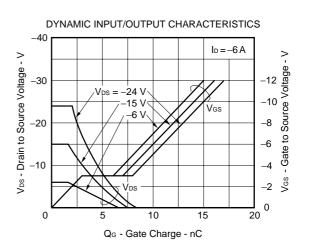












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NEC

 μ PA1717

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